



Room-temperature multiferroic behavior in layer-structured Aurivillius phase ceramics

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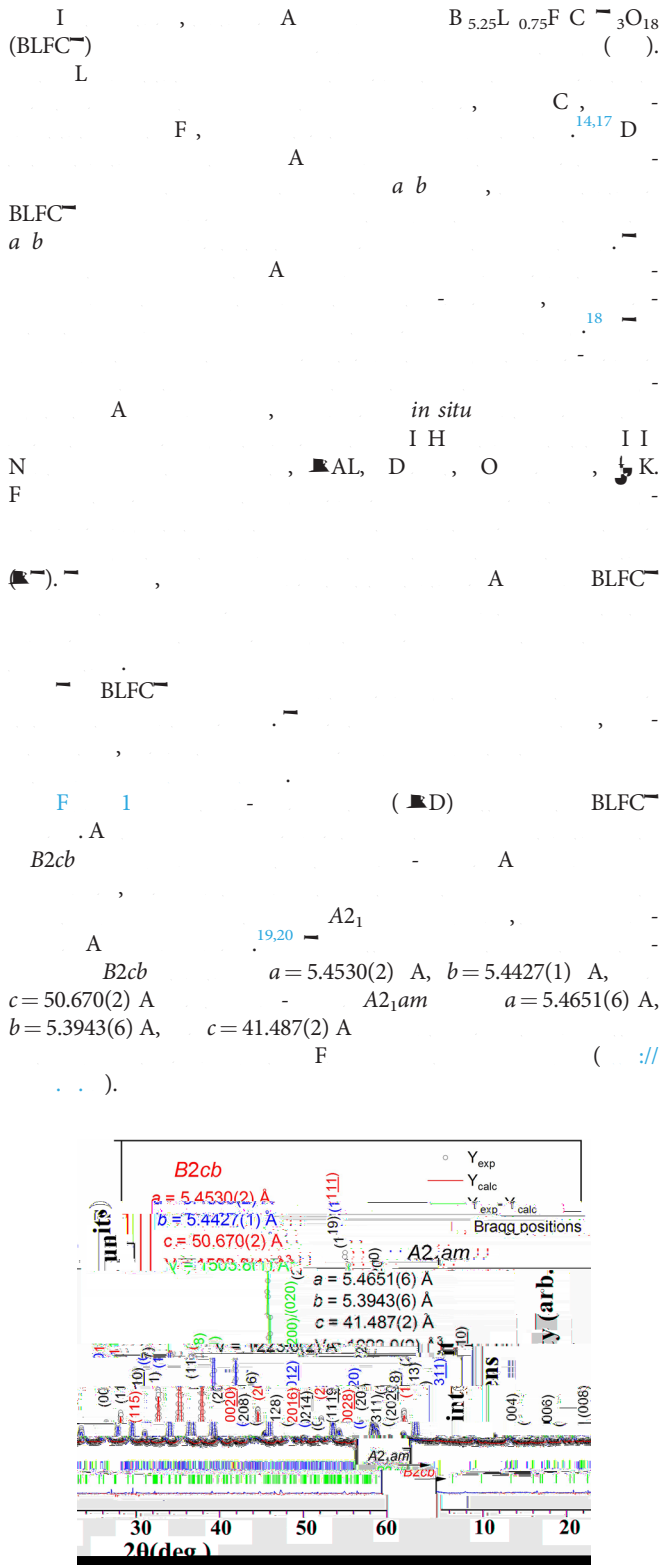


FIG. 1. XRD patterns of BLFC.

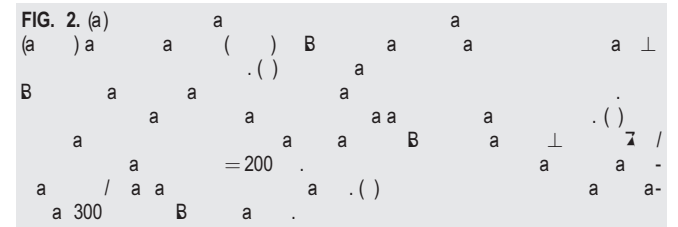
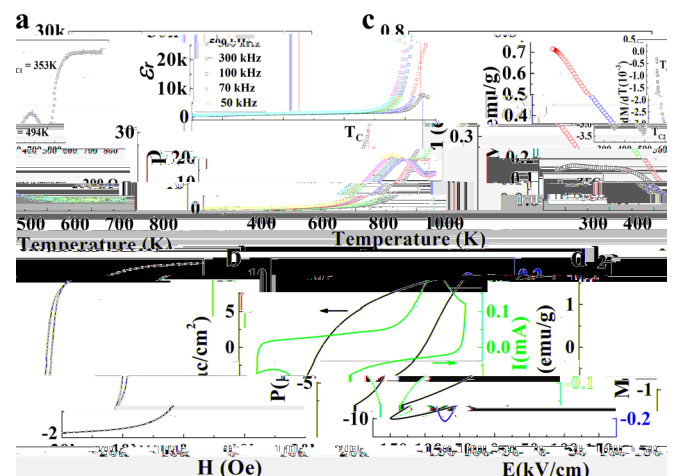
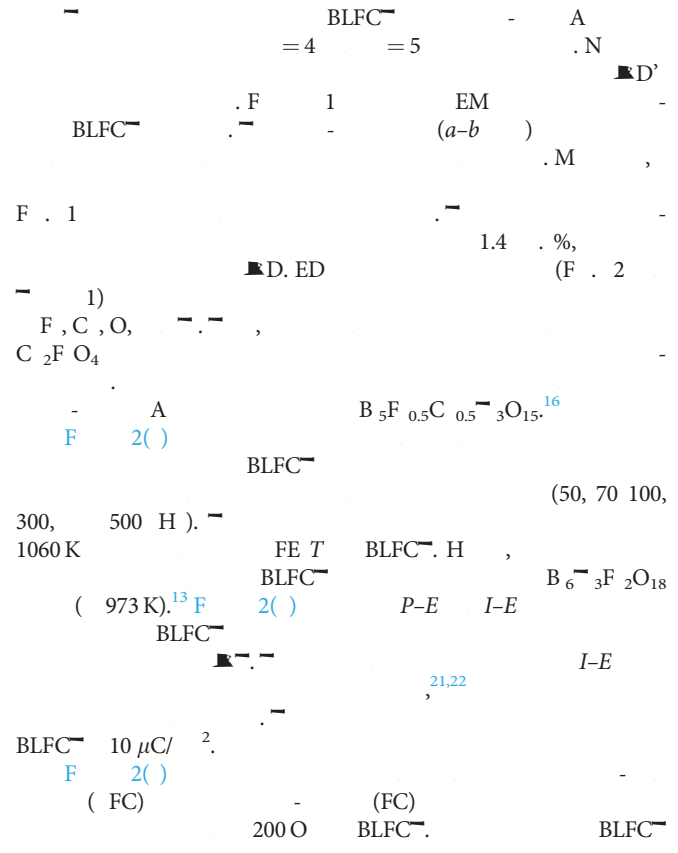


FIG. 2. (a) Raman spectra of BLFC.

~ 494 K
 M/μ_B ,
 $B_6F_2C_{18}O_{18}$ (526 K).²³
 BLFC
 $F^{3+} O F^{3+}, C^{3+} O C^{3+}, F^{3+} O C^{3+}$ ().²⁴
 ED
 ~ 353 K
 FC
 $C_2F_2O_4$
 $C_2F_2O_4$ (460 K)
 $(M) C_2F_2O_4$ 16,25
 $16.235 /$,
 $C_2F_2O_4$ 0.22 0.32 / , 1.4 .%
 $M = 1.85 /$, $F = 2(1.1)$ BLFC
 $M H$
 ~ 425 K 1.58 / .
 $0.27 /$, ED
 BLFC
 $F^{3+} O C^{3+}$
 (DF)
 (A) *ab initio*
 $\mu_F = 2$ $\mu_C = 3$ F C ,
 (GGA)+ μ . I
 BLFC
 $F = 3(1)$, $F^{3+} C^{3+}$ (3.1 2.1 μ_B / ,) ,
 $0.1 \mu_B /$) .
 $F O_6 C O_6$ F / C -
 F O - / . $F = 3(1)$.
 $F^{3+} C^{3+}$,
 (\dots) ,
 $E_{FM} - E_{AFM}$
 $= -144.1$.
 H , (FM)
 43.5 (, 504.6 K), FM
 ~ 1 FC/FC . $F = 2(1)$.
 $a b$
 010
 BLFC
 $F = 4$. I
 399 O .
 $F =$.
 $F =$.

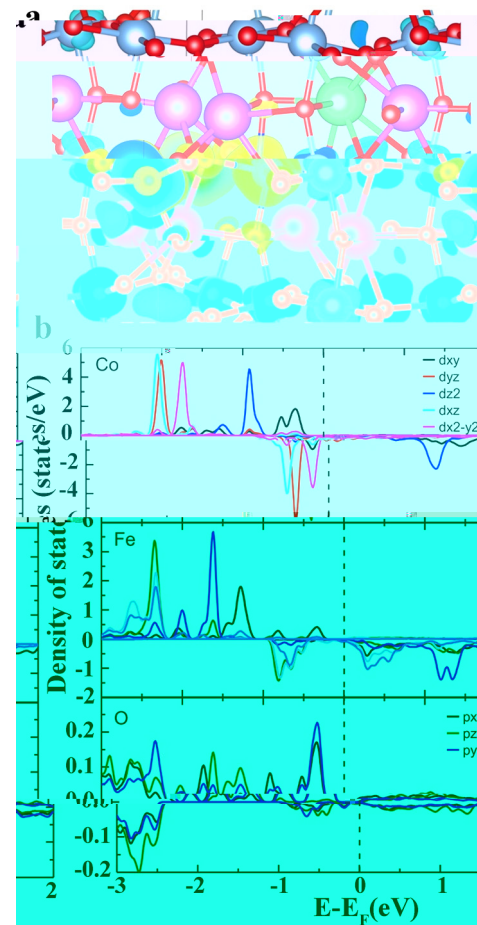


FIG. 3. (a) Crystal structure of BLFC with lattice parameters $a = b = 0.354$ nm, $c = 0.399$ nm, and $\beta = 90^\circ$. (b) Density of states (DOS) for Co, Fe, and O atoms. The Fermi level is set at 0 eV. The DOS is shown in units of states/eV. The legend indicates the orbital contributions: dxy (red), dyz (green), dz2 (blue), dxz (cyan), dx2-y2 (magenta) for Co; px (red), py (green), pz (blue) for O.

~ 399 O .
 $F =$.
 $F =$.
 $F = 4$.
 $(0 1 20)$
 2 . F
 $(2 < H < 5)$,
 $M H$ $F = 2()$ 3. F ,
 $F = 5$
 BLFC
 $F M$
 $5()$. A FM BLFC ,

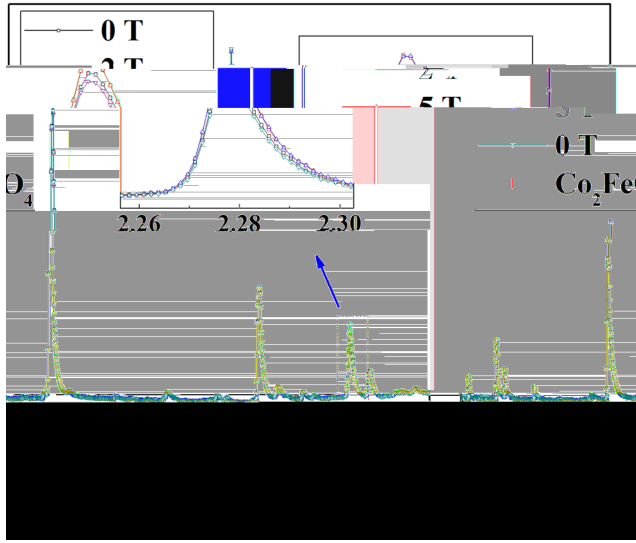


FIG. 4. XRD patterns of BLFC thin films at different magnetic fields (0 T, 2 T, 5 T). The inset shows the shift of the 010 peak with increasing magnetic field.

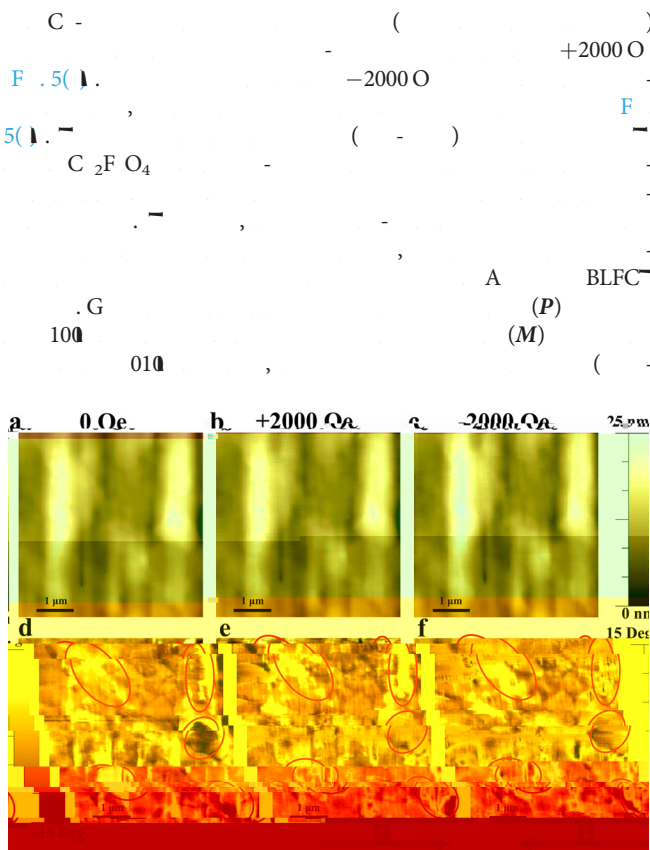


FIG. 5. TEM images of BLFC thin films at different magnetic fields (0 Oe, +2000 Oe, -2000 Oe). (a) HRTEM image at 0 Oe, (b) HRTEM image at +2000 Oe, (c) HRTEM image at -2000 Oe, (d) SAED pattern at 0 Oe, (e) SAED pattern at +2000 Oe, (f) SAED pattern at -2000 Oe.

$T = P \times M$
 BLFC⁻
 I , A BLFC⁻
 F
 C³⁺ O C³⁺, F³⁺ O C³⁺ F³⁺ O F³⁺
 A , C / F
 EM (ED) BLFC⁻
 D . M , D . K , D.
 D I H I I N , AL,
 D , O , K.
 A E D F
 G A A (G N . 2/
 0038/20), C (G N . K2015-0602006), N FC (G
 N . 11474138 11834005). A
 E M (EM)
 IND54 N EM
 EM E, AME E

DATA AVAILABILITY

REFERENCES

1. E , N. D. M , J. F. , N 442, 759 (2006).
2. N. A. , N . M . 6, 21 (2007).
3. J. M. , J. H. , L. C. . N , A . M . 23, 1062 (2011).
4. L. F. H , O. C , J. B , J. L , C. H , H , H , O. G , D. C. L , H. , K , A. J. B , A . F . M . 26, 2111 (2016).
5. N. A. H , J. . C . B 104, 6694 (2000).
6. B. A , M : IL
 B₄-₃O₁₂, A . K 1(58), 499 512 (1949).
7. A. , G. K , M. M. K , J. . : C . M . 11, 3335 (1999).
8. N. . G. . K , M . . E . B 108, 194 (2004).
9. L. K , M , M. , A. A , N. D , N. , M. E. , D. J , J. A . C . . 96, 2339 (2013).
10. L. J. M , G. , G. , K , A. M , L. C. J , C. N , H. , D . 45, 14049 (2016).
11. J. F. , N GA M . 5, 72 (2013).
12. A. . B C. E , B 90, 214109 (2014).
13. J. B. L. , H , G. H. , G. . L , J. L , J. C , J. K. L , A . . L . 96, 222903 (2010).
14. M , C , L. A . . L . 95, 082901 (2009).
15. L. J. , L. , J. D , A . . L . 101, 122402 (2012).

- ¹⁶M. [redacted], [redacted], M. B. [redacted], A. [redacted] B. [redacted], J. [redacted] H. [redacted], [redacted], K. [redacted], L. K. [redacted], [redacted], M. [redacted], [redacted], C. [redacted], [redacted] H. [redacted], A. J. B. [redacted], *J. A. [redacted]* **112**, 073919 (2012).
- ¹⁷J. L. [redacted], H. [redacted], M. J. [redacted], [redacted], K. [redacted], [redacted], *J. A. [redacted]* **102**, 104107 (2007).
- ¹⁸M. G. C. [redacted], *Characterisation of Ferroelectric Bulk Materials and Thin Films* ([redacted], 2014), [redacted].
- ¹⁹[redacted], K. [redacted], J. M. [redacted], [redacted], G. [redacted], K. [redacted], C. J. [redacted], G. [redacted], H. [redacted], A. M. [redacted], J. C. [redacted], M. C. [redacted], I. A. [redacted], C. N. [redacted], C. J. [redacted], H. [redacted], *J. M. [redacted] C. [redacted] C* **6**, 2733 (2018).
- ²⁰[redacted], K. [redacted], I. [redacted], G. [redacted], M. [redacted], C. J. [redacted], H. [redacted], *J. [redacted] C. [redacted]* **122**, 15733 (2018).
- ²¹L. J. [redacted], F. L. [redacted], [redacted], *J. A. [redacted] C. [redacted]* **97**, 1 (2014).
- ²²H. [redacted], F. I. [redacted], G. [redacted], H. N. [redacted], H. [redacted], [redacted], J. [redacted], [redacted], [redacted], G. [redacted], M. J. [redacted], *J. A. [redacted] D. [redacted]* **1**, 107 (2011).
- ²³J. [redacted], L. [redacted], [redacted], [redacted], [redacted], J. D. [redacted], [redacted], [redacted], A. [redacted], *[redacted] L. [redacted]* **101**, 012402 (2012).
- ²⁴B. [redacted], J. [redacted], J. C. [redacted], [redacted], L. [redacted], [redacted], [redacted], J. D. [redacted], [redacted], [redacted], A. [redacted], *[redacted] L. [redacted]* **104**, 062413 (2014).
- ²⁵[redacted], M. [redacted], [redacted], N. B. [redacted], [redacted], [redacted], **11**, 719 (2009).